

# **TEST / CALIBRATION REPORT**

# EMC / EMI Test Report for MECO Current Transducer With 85V To 265V AC Aux. Supply

Testing as per BS EN 61326 (Edition 1999)



# **ELECTRONICS REGIONAL TEST LABORATORY (WEST)**

MINISTRY OF COMMUNICATIONS & INFORMATION TECHNOLOGY, (STQC Dte.)

## Government of India

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#### **MEMORANDUM**

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- 2. The reprot shall not be regarded in any way diminishing the normal contractual responsibilities / obligations between the customer and ERTL (W).
- 3. The results reported in this report are valid only at the time of and under the stated conditions of the measurements.

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#### 1. SCOPE

Service Request No : ERTL (W)/20031936 1.1 : 1<sup>st</sup> – OCT - 2003 1.1.1 Service Request finalised on Requested by : MECO INSTRUMENTS PVT. LTD. 1.2 (Name and address of manufacturer) 301, BHARAT INDUSTRIAL ESTATE, T.J.ROAD, SEWREE, MUMBAI - 400 015 Description Manufacturer and Type No.\* Serial No\* 1.3 ltem Qty No.

|     | 1. ELECTRICAL<br>TRANSDUCER | 01 MECO INSTRU<br>CMT | UMENTS PVT. LTD / 013 |  |
|-----|-----------------------------|-----------------------|-----------------------|--|
| 1.4 | Test specifications         | BS EN 61326           | : 1999                |  |

| 1.5 | Lab Ambient           | Temperature : (25 +_2) deg.C<br>Humidity : (55 +_5) % RH  |
|-----|-----------------------|---|
| 1.6 | Test Equipment used : | <ol> <li>EMI/034 : RS Chamber (Keytek, G-Strip)</li> <li>EMI/036 : RF Signal Generator (HP, 8648 A) for C.S and R.S. tests</li> <li>EMI/037 : RF Amplifier (AR, 25A100) for R.S test</li> <li>EMI/044 : Three Phase Immunity Test System</li> <li>CRI/064 : Spectrum Applycer (HP8568P) for CE</li> </ol> |

- CPU/064 : Spectrum Analyser (HP8568B) for CE
   EMI/048 : ESD Gun for ESD test



\* As declared by Manufacturer

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## 2.0 EQUIPMENT UNDER TEST (EUT)

## 2.1 Description

EUT is a Electrical Transducer CMT , which operates on auxiliary supply between 85 V AC to 265 V AC, 50 Hz, single phase. EUT was made operational.

## 2.2 Operating modes during normal testing.

EUT is supplied with an auxiliary supply between 85 V AC to 265 V AC, 50Hz, single phase. An Input supply of 5 A AC , 50Hz, Single phase is given at input terminals 12 and 13. The output of EUT shall be loaded with rated resistive load for normal operations & all applicable tests. The output current shall remain in the range of 4 to 20 mA DC at output 1 & 2 before and after all tests. EUT was made operational with rated input voltage & output was loaded with resistive load during immunity tests.

## 2.3 Functional check for all immunity tests.

### Performance Criterion - 'A'

During testing, normal performance within specification limits.

### Performance Criterion - 'B'

During testing temporary degradation or loss of function is allowed which is self recovering e. g. during testing output observed current may deviate by allowed margin  $\pm 0.5$  %. However after the test EUT shall function normal within specified limits.

### Performance Criterion - 'C'

During testing, temporary degradation or loss of function or performance which requires operator intervention or system reset occurs.



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## 3.0 Test Results

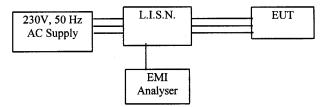
## 3.1 CONDUCTED EMISSION

**Test Rationale: To** measure emissions of the EUT\* (referenced to Earth) on Power Mains and to compare them with specified limits to ascertain that the EUT will not disturb other equipment by generating such emissions above a certain limit

- a) Test Condition
  - Set-up Measurement Range Measurement On Line Voltage Line Frequency

As per BS EN 55022 : 1995 150 kHz – 30 MHz Spectrum Analyser 230 V AC single phase, 50 Hz supply 50 Hz

- b) Receiver Bandwidth 9 KHz Detectors Quasi – peak and Average Configuration Conforming to CISPR 16 -
- c) Test procedure



EUT supplied with 230V 3 phase, 50 Hz AC supply through an LISN. Emission of the EUT were measured with a Spectrum Analyser .

## d Requirements

EUT emissions shall be below following Class 'B' limits

| Freq.<br>(MHz) | Limits<br><b>(dBuV)</b> |         |
|----------------|-------------------------|---------|
|                | Quasi-Peak              | Average |
| 0.15-0.5       | 79                      | 66      |
| 0.5-5          | 73                      | 60      |
| 5-30           | 73                      | 60      |

## e Observations

Measurements with peak detector were carried. Pl. see Graph at page 11 of 11

f Results



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## 3.2 RADIATED EMISSION

## **Test Rationale :**

To measure emissions of the EUT radiated into space and to compare them with specified limits to ascertain that the EUT will not disturb other equipment by generating such emissions above a certain limit.

a) Test Condition : Set-up

As per BS EN 55022 : 1995

Frequency Range 30 MHz – 1000MHz

EUT in normal operating condition with output loaded with full resistive load.

b) Receiver:

Bandwidth Detectors Antenna 120 KHz QP Bi-Conical (For 30 – 200 MHz) Log-Periodic (For 200 – 1000 MHz) Conforming to CISPR 16-1.

## c) Test procedure

Configuration

- Ambient measurements carried out first with EUT "off" and peaks noted
- > EUT was switched "ON" and Emission peaks noted.
- Antenna height and position were changed to maximize Emissions.
- A table of Emission and corresponding Ambient was then drawn up.
- \* "Ambient" and "Emission" peaks were compared. Peaks with a difference of less than 5 dB were discarded.

### d) Requirements

EUT emissions shall be below following limits

| Freq.    | Limits   |
|----------|----------|
| (MHz)    | (dBuV/m) |
|          | QP       |
| 30-230   | 50       |
| 230-1000 | 57       |

## e) Observations

For results PI. refer page 10 of 11 for details

f) Results



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## 3.3 Conducted susceptibility

## **Test Rationale:**

To check immunity characteristics of the EUT against Conducted RF Susceptibility levels.

a) Test Condition:

| Test Condition:<br>Set-up            | As per BS EN 61000 – 4 –6 : 1996     |
|--------------------------------------|--------------------------------------|
| Mode of simulation:<br>Test Voltage: | Injected on power mains<br>3 V r.m.s |
| Frequency range                      | 150 KHz - 80 MHz                     |

Frequency range150 KHz - 80 MHzSimulationUsing coupling/ decoupling NetworkEUT in normal operating condition as per Sr. No. 2.2

## c Test procedure:

Conducted RF level was injected to power mains by coupling/ decoupling network along the subject frequency range & EUT performance was monitored before and after the test as per Sr. No. 2.2.

## d Requirement:

Performance Criterion 'A', Normal Operation of the EUT with specified performance as per Sr. No. 2.2

e Observations

Operation of the EUT was found normal before and after the test as per Sr. No. 2.2.

f Results Complied



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## 3.4 RADIATED SUSCEPTIBILITY (RS)

## **Test Rationale**

To check immunity characteristics of the EUT in the presence of radiated fields generated by intentional emitters like Radio /TV transmitters, wireless equipment and the like by illuminating the EUT by such frequency

## a) Test Condition :

Set-upAs per BS EN 61000-4-3 : 1995Frequency Range80 MHz - 1000 MHzField Strength10 V/mEUT in normal operating condition as per Sr. NO. 2.2

## b) Test procedure

EUT including housing was subjected to field strength of 10 V/m in G-Strip chamber & functional performance was observed over the subject frequency range after the test.

## c) Requirements

Performance Criterion A ,Operation of the EUT shall be normal before & after the test as per Sr. No. 2.2.

## d) Observations

Operation was found normal before and after the test as per Sr. No. 2.2. No deviation from actual operating condition could be observed.

## e) Results



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## 3.5 ELECTROSTATIC DISCHARGE (ESD)

## Test Rationale :

To check immunity characteristics of the EUT against Discharge of Static Electricity that may occur when a charged operator touches the EUT.

| a) | Test Condition:<br>Set-up | As per BS EN 61000-4-2 : 1995   |
|----|---------------------------|---|
|    | Mode of simulation:       | Contact Discharge on conductive surfaces &<br>Air Discharge on non- conductive surfaces |
|    | Test level                | 2   |
|    | Test Voltage:             | Contact Discharge: 4kV  |
|    | -                         | Air Discharge: 8kV  |
|    | No. of Discharges         | 10  |
|    | Polarity                  | Positive and Negative   |
|    | Points of Discharge       | Contact Discharge   |
|    | -                         | Maintenance screws, conducting metal surfaces   |
|    |                           | Air Discharge :   |
|    |                           | Insulating surfaces   |

## Simulation Using ESD Gun EUT in normal operating condition as per Sr. No. 2.2

## c Test procedure :

- EUT initially subjected to indirect discharge on VCP and HCP.
- EUT was then screened in continuous discharge mode.
- At susceptible points, ten single discharges were applied.

## d Requirement :

Performance Criterion B ,temporary degradation or loss of function is allowed during the test. After the test EUT shall function normal as per Sr. No. 2.2.

## e Observations

Operation of the EUT was found to be normal during and after the test as per Sr. No. 2.2.

## f Results



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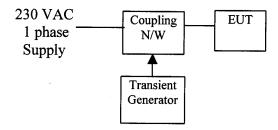
## 3.6 ELECTRICAL FAST TRANSIENTS (EFT)

## **Test Rationale :**

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To check immunity characteristics of the EUT against transients generated by inductive load switching, Relay contact bouncing, switching of high voltage switchgear and the like

- Test Condition : Set-up As per BS EN 61000-4-4 : 1995 Pulse 5/50 ns Modes Common and Differential **Test Level** 3 Puise Amplitude 2kV Pulse Rep. Rate 5 kHz Polarity Positive and Negative Duration of test in each mode 60 s Simulation On 230 V single phase AC supply by Direct Injection EUT in normal operating condition as per Sr. No. 2.2.
- c Test procedure :



Transients generated by the generator were coupled to the 230 VAC Supply through a coupling N/W.

## d Requirements :

Performance Criterion B ,temporary degradation or loss of function is allowed during the test. After the test EUT shall function normal as per Sr. No. 2.2.

## e Observations

Operation of the EUT was found to be normal during and after the test as per Sr. No. 2.2.

f Results



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4.0 General Remarks: Nil

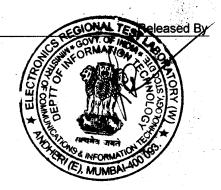
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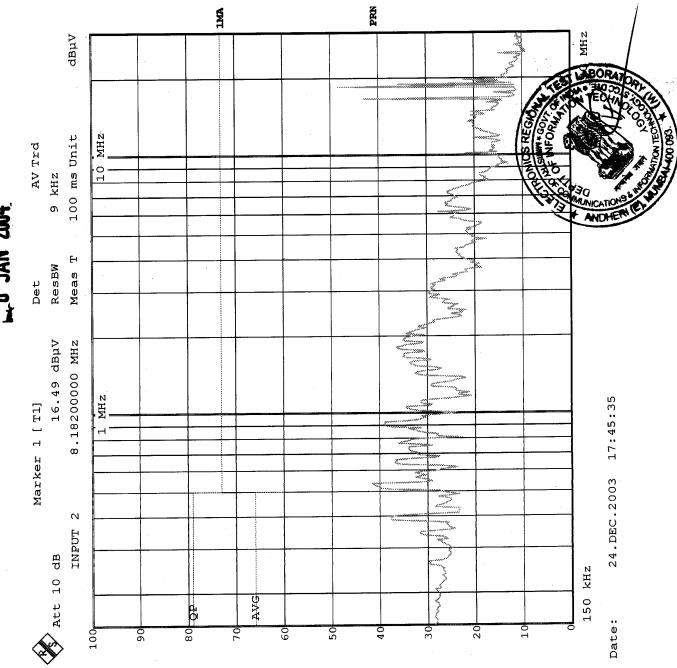
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## **Radiated Emission Test Results**

| SR.NO. | FREQUENCY<br>(MHz) | EMISSIONS OBSERVED<br>(dBuV/m) | LIMITS<br>(dBuV/m) | REMARKS |
|--------|--------------------|--------------------------------|--------------------|---------|
| 1.     | 40.78              | 22.50                          | 50.00              | Pass    |
| 2.     | 47.64              | 27.10                          | 50.00              | Pass    |
| 3.     | 63.04              | 33.60                          | 50.00              | Pass    |
| 4.     | 76.20              | 20.60                          | 50.00              | Pass    |
| 5.     | 104.20             | 21.00                          | 50.00              | Pass    |
| 6.     | 127.60             | 25.70                          | 50.00              | Pass    |
| 7.     | 132.40             | 22.35                          | 50.00              | Pass    |
| 8.     | 135.00             | 22.30                          | 50.00              | Pass    |
| 9.     | 171.90             | 25.45                          | 50.00              | Pass    |
| 10.    | 606.80             | 32.00                          | 57.00              | Pass    |
| 11.    | 618.40             | 30.90                          | 57.00              | Pass    |
| 12.    | 630.40             | 31.25                          | 57.00              | Pass    |

Testing has been carried out at 3- meter test distance and limits have been modified accordingly.





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## **OUR ACCREDITATION STATUS**

ERTL (W) set up under the STQC Directorate, Ministry of Communications & Information Technology, Govt. of India has been accreditated under number of national / international systems as follows :

| SYSTEM  | AREA   | STATUS   |
|---|--|--|
| IECQ<br>(International Electro-technical<br>Commission on Quality Assessment<br>System for Electronic Components) | Component Testing <ul> <li>Resistors (Fixed)</li> <li>Capacitors (Fixed)</li> </ul>              | Accreditated as ITL<br>(Independent Test<br>Laboratory)                |
| NABL (C), India<br>National Accreditational Board for<br>Test & Calibration laboratories<br>(Calibration System)  | Calibration<br>• Electro-technical discipline<br>• Thermal discipline<br>• Mechanical discipline | Accreditated Calibration Laboratory                                    |
| NABL(T), India<br>National Accreditational Board for<br>Test & Calibration laboratories<br>(Testing System)       | Electronic & Electrical Testing  | Accreditated Test Laboratory   |
| IECEE-CE-Scheme   | <ul> <li>Mains Operated Electronic<br/>Consumer Products</li> </ul>                              | Approved as a CB test<br>Laboratory                                    |
| Other recognisation   |  | Recognised by CSPO of State Govt.,<br>DOT, Naval Docyard,<br>LCSO etc. |
|   |  |  |